

Silicon diffused power transistors**BUX86; BUX87**

High-voltage, high-speed, glass-passivated npn power transistors in TO-126 envelopes, for use in converters, inverters, switching regulators, motor control systems and switching applications.

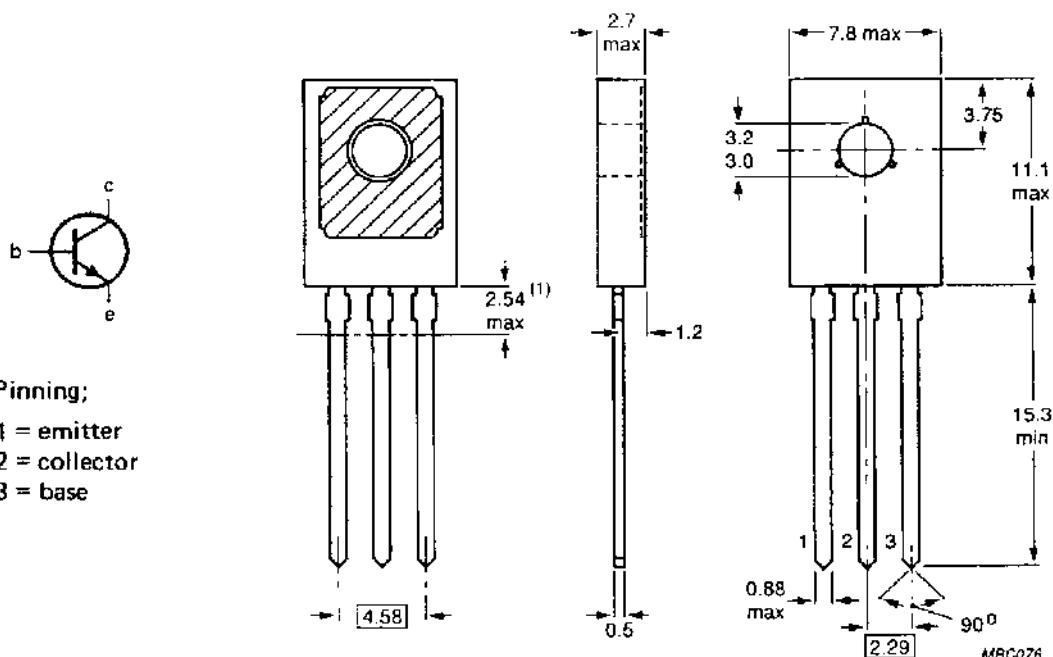
QUICK REFERENCE DATA

		BUX86	BUX87
Collector-emitter voltage (peak value; $V_B = 0$)	V_{CESM}	max. 800	1000 V
Collector-emitter voltage (open base)	V_{CEO}	max. 400	450 V
Collector-emitter saturation voltage	V_{CEsat}	max. 1	V
Collector current (DC)	I_C	max. 0,5	A
Collector current (peak value)	I_{CM}	max. 1	A
Total power dissipation up to $T_{mb} = 60^\circ\text{C}$	P_{tot}	max. 20	W
Fall time	t_f	typ. 0,4	μs

MECHANICAL DATA

Dimensions in mm

Fig. 1 TO-126.



Collector connected to metal part of mounting surface.

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RATINGS Limiting values in accordance with the Absolute Maximum System (IEC 134)

		BUX86	BUX87	
Collector-emitter voltage (peak value; $V_{BE} = 0$)	V_{CESM}	max. 800	1000	V
Collector-emitter voltage (open base)	V_{CEO}	max. 400	450	V
Emitter-base voltage (open collector)	V_{EBO}	max. 5	5	V
Collector current (DC)	I_C	max. 0,5	0,5	A
Collector current (peak value) $t_p = 2$ ms	I_{CM}	max. 1	1	A
Base current (DC)	I_B	max. 0,2	0,2	A
Base current (peak value)	I_{BM}	max. 0,3	0,3	A
Reverse base current (peak value) (note 1)	$-I_{BM}$	max. 0,3	0,3	A
Total power dissipation up to $T_{mb} = 60$ °C	P_{tot}	max.	20	W
Storage temperature range	T_{stg}	–65 to + 150	–65 to + 150	°C
Junction temperature	T_j	max. 150	150	°C
THERMAL RESISTANCE				
From junction to mounting base	$R_{th\ j-mb}$	=	4,5	K/W
From junction to ambient in free air	$R_{th\ j-a}$	=	100	K/W
CHARACTERISTICS				
Collector-cut-off current (note 2)				
$V_{CE} = V_{CESM\max}; V_{BE} = 0$	I_{CES}	max.	100	µA
$V_{CE} = V_{CESM\max}; V_{BE} = 0; T_j = 125$ °C	I_{CES}	max.	1	mA
DC current gain				
$I_C = 50$ mA; $V_{CE} = 5$ V	h_{FE}	min.	26	
	h_{FE}	typ.	50	
	h_{FE}	max.	125	

Notes

1. Turn-off current.
2. Measured with a half-sinewave voltage (curve tracer).

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Emitter cut-off current

 $I_C = 0$; $V_{EB} = 5$ V I_{EBO} max. 1 mA

Saturation voltage

 $I_C = 0,1$ A; $I_B = 10$ mA V_{CEsat} max. 0,8 V $I_C = 0,2$ A; $I_B = 20$ mA V_{CEsat} max. 1,0 V $I_C = 0,2$ A; $I_B = 20$ mA V_{BEsat} max. 1,0 V

Collector-emitter sustaining voltages

 $I_C = 100$ mA; $I_{Boff} = 0$; $L = 25$ mH

	BUX86	BUX87
V_{CEO} sust	min. 400	450
		V

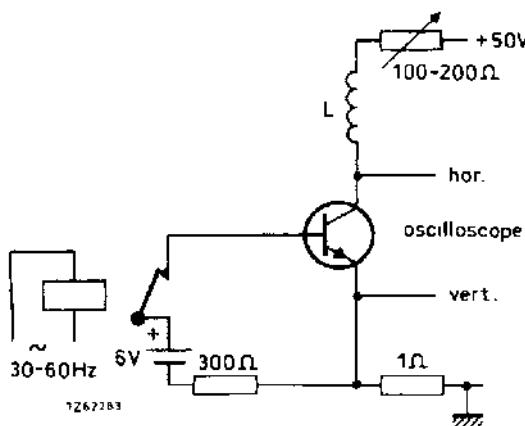
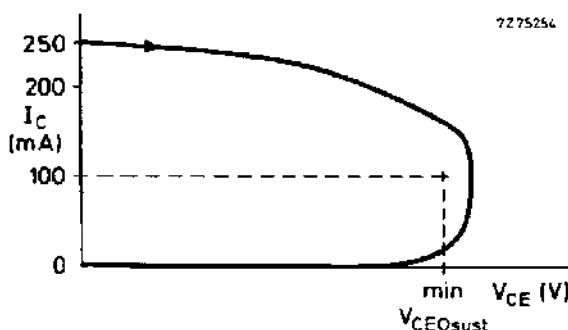
Fig. 2 Test circuit for V_{CEO} sust.

Fig. 3 Oscilloscope display for sustaining voltage.

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CHARACTERISTICS (continued)

Transition frequency at $f = 1$ MHz $I_C = 50$ mA; $V_{CE} = 10$ V f_T typ 20 MHz

Switching times

 $I_{Con} = 0,2$ A; $V_{CC} = 250$ V $I_{Bon} = 20$ mA; $-I_{Boff} = 40$ mA

Turn-on time

 t_{on} typ 0,25 μ s
max. 0,5 μ s

Turn-off: Storage time

 t_s typ 2 μ s
max. 3,5 μ s

Fall time

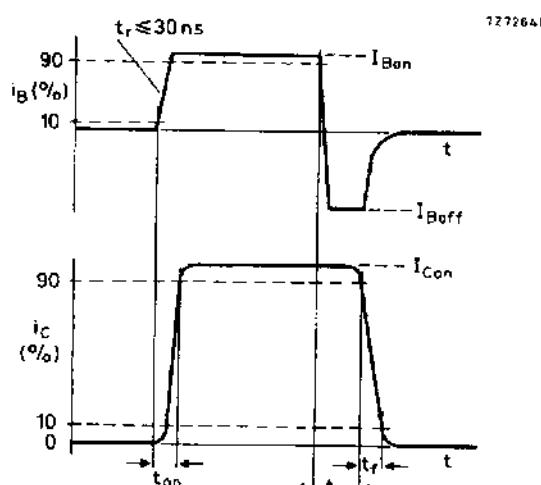
 t_f typ 0,4 μ sFall time, $T_{mb} = 95$ °C t_f max. 1,3 μ s

Fig. 4 Switching times waveforms with resistive load.

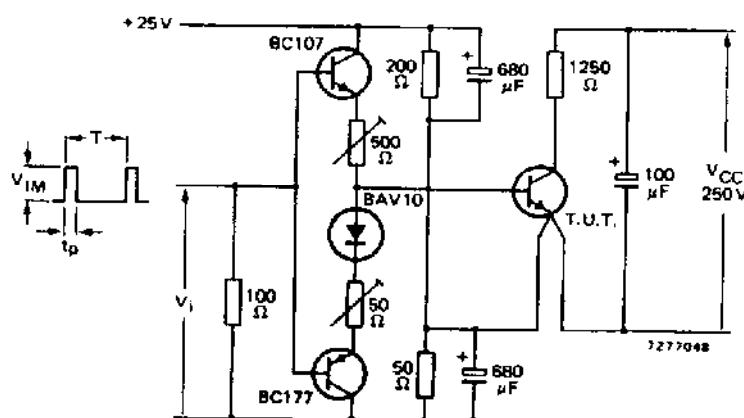
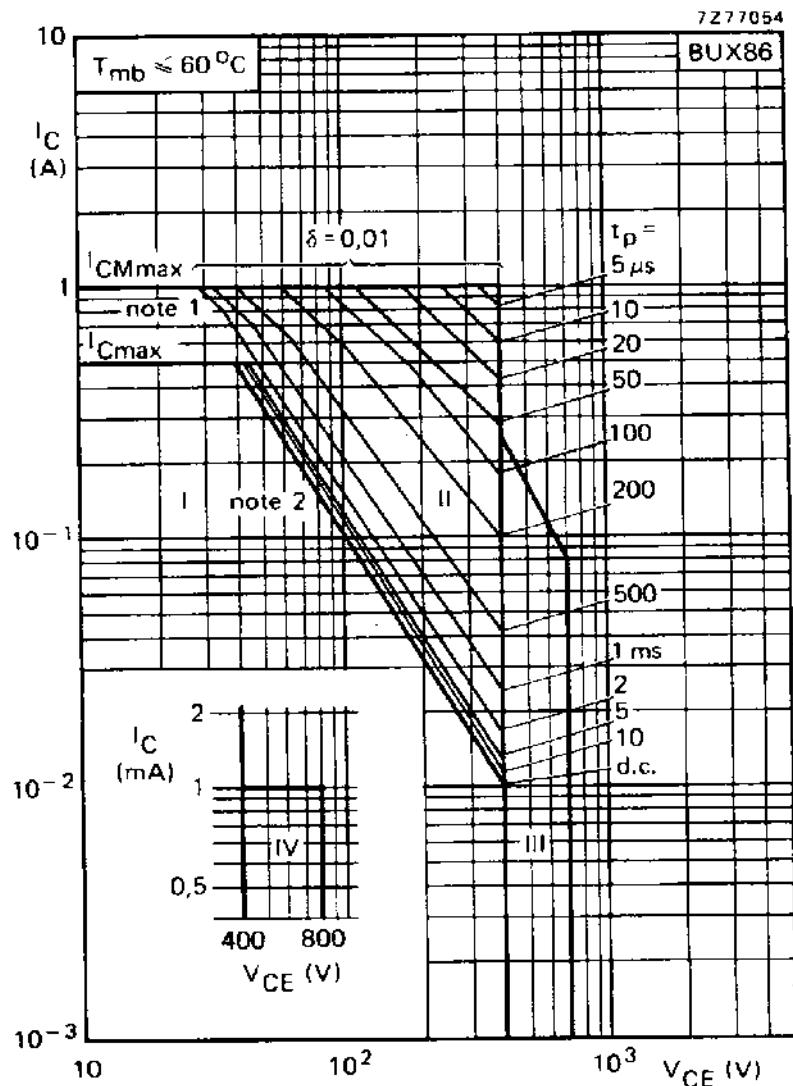


Fig. 5 Test circuit resistive load.

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1. Peak max lines.
2. Second-breakdown limits.

I Region of permissible DC operation

II Permissible extension for repetitive pulse operation

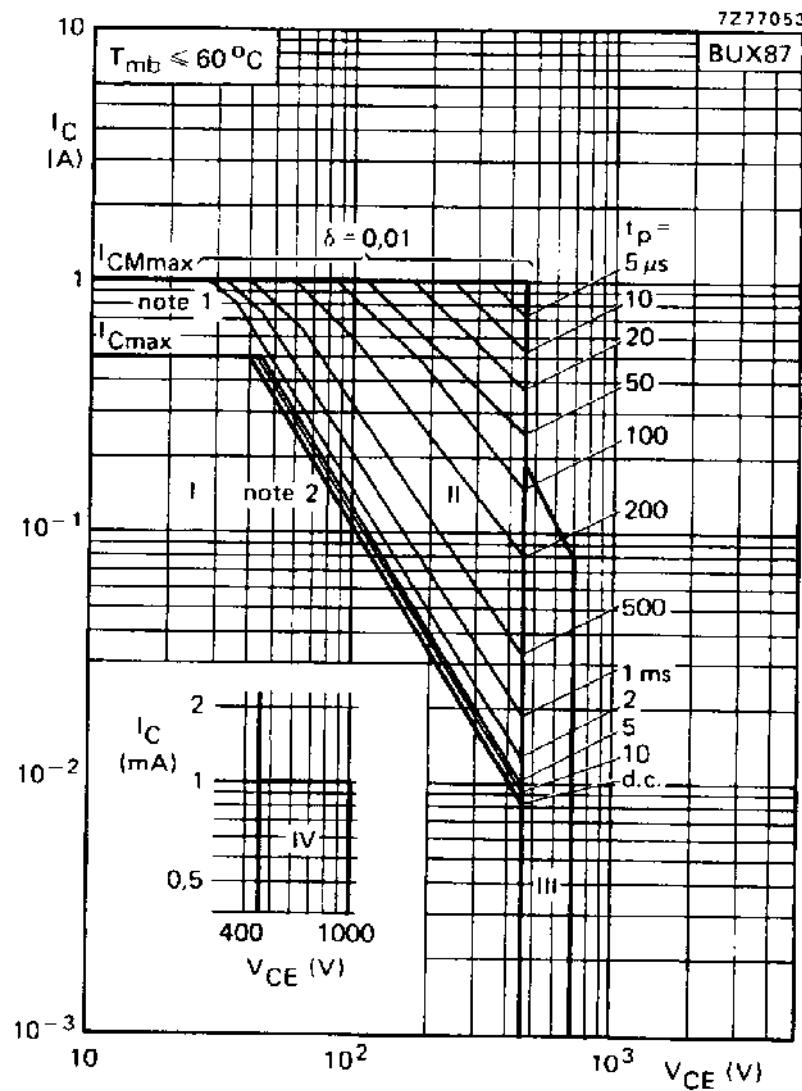
III Area of permissible operation during turn-on in single-transistor converters, provided $R_{BE} \leq 100 \Omega$ and $t_p \leq 0.6 \mu\text{s}$

IV Repetitive pulse operation in this region is permissible, provided $V_{BE} \leq 0$ and $t_p \leq 2 \text{ ms}$

Fig. 6 Safe operating area.

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1. $P_{peak\ max}$ lines.
 2. Second-breakdown limits.
- I Region of permissible DC operation
 - II Permissible extension for repetitive pulse operation
 - III Area of permissible operation during turn-on in single-transistor converters, provided $R_{BE} \leq 100 \Omega$ and $t_p \leq 0,6 \mu s$
 - IV Repetitive pulse operation in this region is permissible provided $V_{BE} \leq 0$ and $t_p \leq 2$ ms

Fig. 7 Safe operating area.

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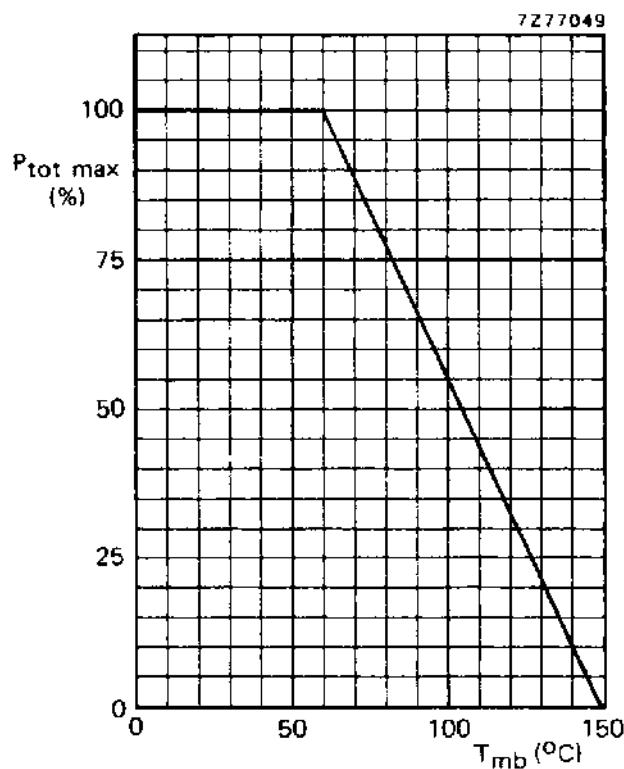


Fig. 8 Power derating curve.

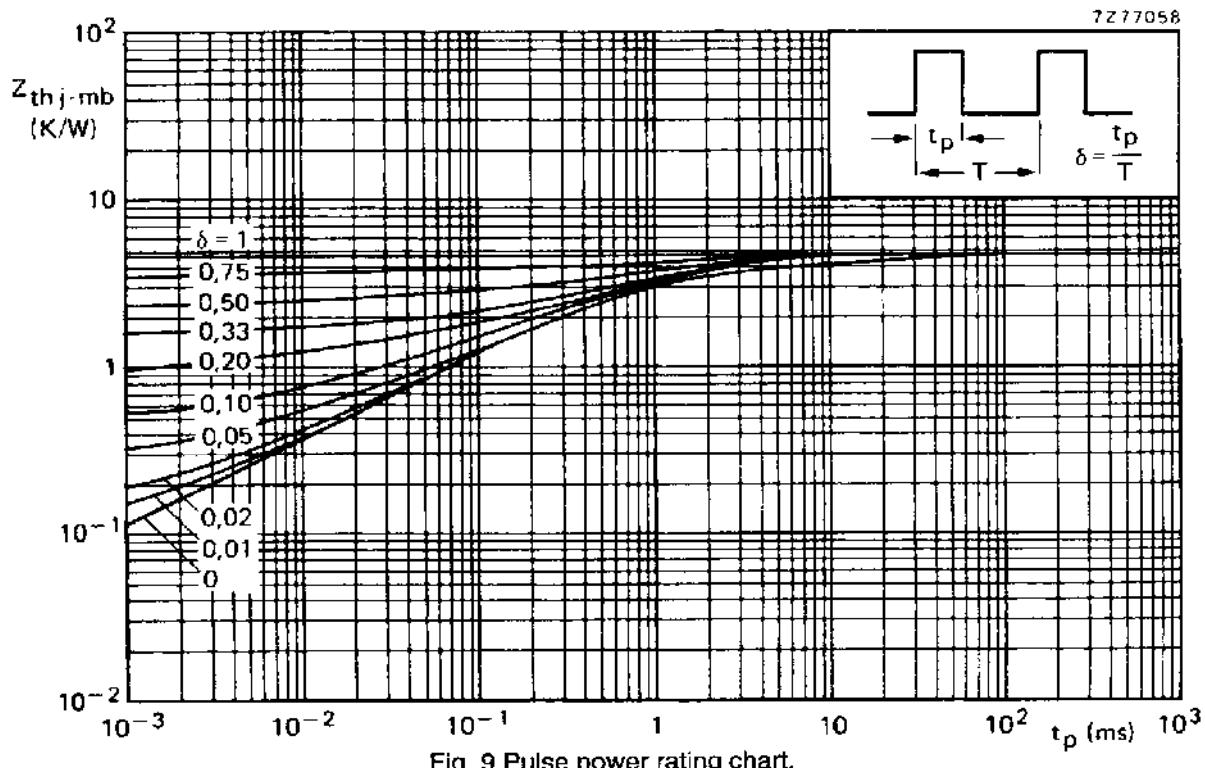


Fig. 9 Pulse power rating chart.

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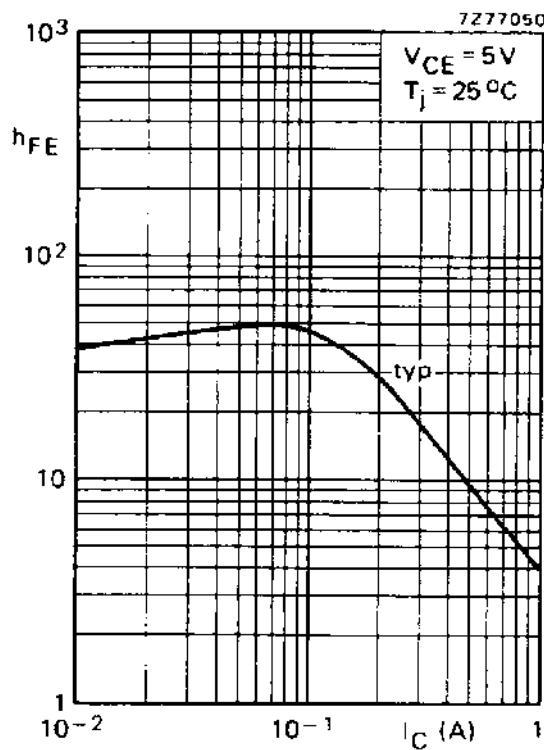


Fig. 10 Typical DC current gain.

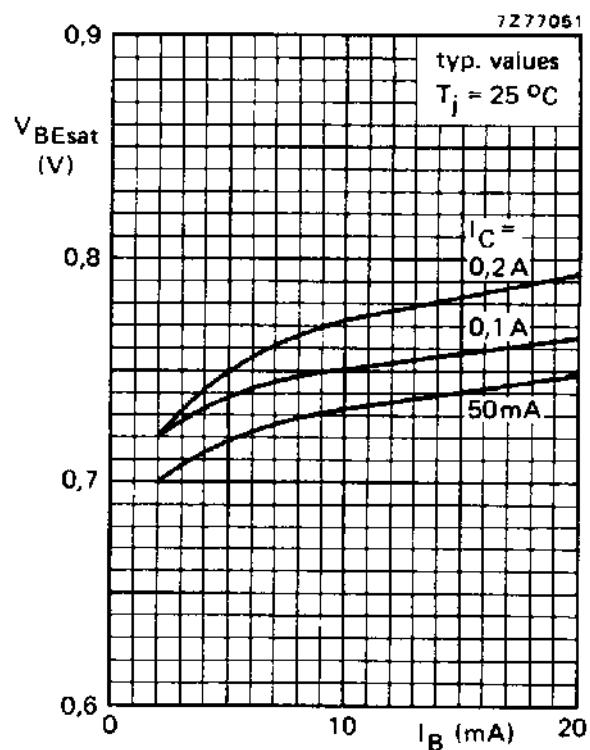


Fig. 11 Typical base-emitter voltage.

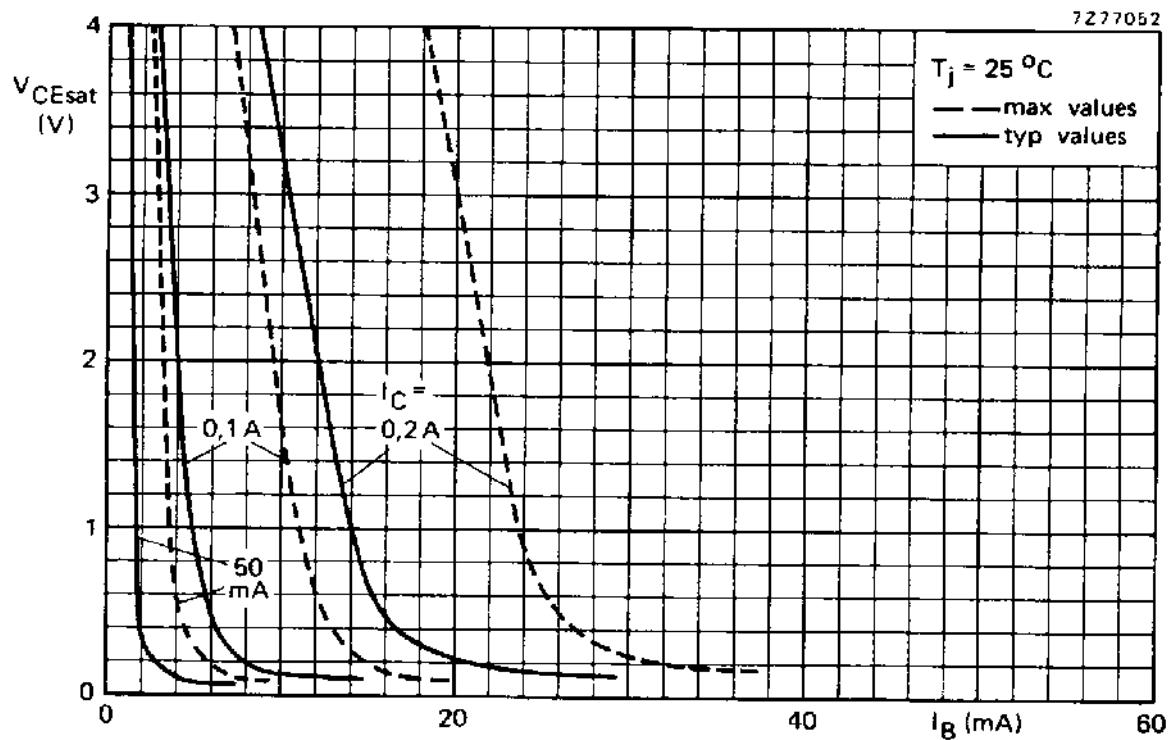


Fig. 12 Typical collector-emitter saturation voltage.